

Notice of References Cited	Application/Control No. 10/720,110	Applicant(s)/Patent Under Reexamination TAKAYUKI NAKAMURA	
	Examiner Alex Liew	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,226,416	05-2001	Ohshima et al.	382/289
*	B	US-6,614,928	09-2003	Chung et al.	382/154
	C	US-			
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	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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